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150:15 U.S. PTO

**NONPROVISIONAL PATENT
APPLICATION TRANSMITTAL RULE §1.53(b)
IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

AREN'T FOX KINTNER PLOTKIN & KAHN, PLLC
1050 Connecticut Avenue, NW
Suite 400
Washington, DC 20036-5339
Telephone: (202) 857-6000
Facsimile: (202) 638-4810

Docket Number: 107337-00056Date: January 26, 2004Customer Number: 004372

Mail Stop: Patent Application
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Transmitted herewith for filing under 37 C.F.R. §1.53(b) is a nonprovisional patent application:

For (Title): SEMICONDUCTOR TESTING CIRCUIT, SEMICONDUCTOR STORAGE DEVICE, AND SEMICONDUCTOR TESTING METHOD

By (Inventors): Syuichi SAITO (Aichi, Japan)

- 57 pages of Specification/Claims 1-18/Abstract are attached.
- Formal drawings (Figs. 1-19; 19 sheets) are attached.
- A Declaration and Power of Attorney is attached.
- Priority of Japanese Application Number 2003-036125 filed February 14, 2003, is claimed under 35 U.S.C. §119.
- A certified copy of the above corresponding foreign application is attached.
- An Information Disclosure Statement is attached, with Form PTO-1449, and 2 references.
- An Assignment of the invention to FUJITSU LIMITED is attached, with Form PTO-1595 and a check for \$40.00.

The filing fee is calculated below and includes claim status after entry of any Preliminary Amendment noted above:

SMALL ENTITY			LARGE ENTITY		
FOR:	NO. FILED	NO. EXTRA	OR	RATE	FEES
BASIC FEE			OR		\$ 770
TOTAL CLAIMS	18 - 20	= 0	OR	x 18	\$ 0
INDEP CLAIMS	5 - 3	= 2	OR	x 86	\$ 172
<input type="checkbox"/> MULTIPLE DEPENDENT CLAIMS			OR	+290	\$ 0
			OR	TOTAL	\$ 942

- Check number 372359 in the amount of \$982.00 (\$942.00 for the Filing Fee and \$40.00 for the Assignment Recordation Fee) is attached. Please charge any fee deficiency or credit any overpayment to Deposit Account Number 01-2300.

Respectfully submitted,



Charles M. Marmelstein
Registration Number 25,895

CMM:vmh

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